Shenzhen CTA Testing Technology Co., Ltd.



Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	FCC PART 15.247
Report Reference No FCC ID	CTA24042300701 2BF6Z-L617
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Date of issue	Apr. 25, 2024
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TESTING	Room 1409, Building 3, NO.2, Research And Development Fifth
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SIN	
Address Test specification Standard Shenzhen CTA Testing Technology	CHINA FCC Part 15.247
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Report No.: CTA240423007	01	Page 2 of 50
CTATESTING	TEST REPOR	
Equipment under Test	: IINE Wireless Controller	CTA TESTING
Model /Type	: L617	
Listed Models	: L746, L796, L828, L708, L709, L	994, L856, L695, L696, L807
Applicant	Dongguan Liangzhi Electronic	Co., Ltd.
Address	TE	esearch And Development Fifth Road, an City, Guangdong Province, CHINA
Manufacturer	: Dongguan Liangzhi Electronic	Co., Ltd.
Address	-	esearch And Development Fifth Road, an City, Guangdong Province, CHINA
Test Res	sult:	PASS
	(CTA)	TESI

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Report No.: CTA24042300701

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		CTATESIN	
		TATESTING	ESTING
		TATES.	CTATESTING

1 TEST STANDARDS

The tests were performed according to following standards:

FCC Rules Part 15.247: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. ANSI C63.10-2013: American National Standard for Testing Unlicensed Wireless Devices

2 SUMMARY

2.1 General Remarks

2.1 General Remarks		
Date of receipt of test sample		Apr. 16, 2024
-	514	
Testing commenced on	CO. C. C. C.	Apr. 16, 2024
Testing concluded on	:	Apr. 25, 2024

2.2 Product Description

Testing co	mmenced on		Apr. 16, 2024	- CTA	
Testing cor	ncluded on	:	Apr. 25, 2024	Constant of the second se	GTA C
2.2 Pro	oduct Descript	tion			
Product Na	ame:	IINE Wire	less Controller		
Model/Typ	e reference:	L617	10		
Power sup	oply:	DC 3.7V F	From battery and DC 5	5.0V From external circuit	
PC information (Auxiliary to testing Lab	test supplied by	Model: E4 Trade Mai	170C rk: thinkpad	ATES	TESTING
Hardware	version:	V1.0	Constant of the second s		K CTA
Software v	/ersion:	V1.0		C	
Testing sa	mple ID:		23007-1# (Engineer sa 23007-2# (Normal sam		
Bluetooth	1:				
Supported	Туре:	Bluetooth	BR/EDR		
Modulation	n:	GFSK, π/4	4DQPSK, 8DPSK	oTI	NG
Operation	frequency:	2402MHz	~2480MHz	TATES	
Channel n	umber:	79		CTA CT	
Channel s	eparation:	1MHz		Constant of the second s	G
Antenna ty	/pe:	PCB anter	nna		C
Antenna g	ain:	-1.42445	dBi		

2.3 Equipment Under Test

Power supply system utilised

2.3 Equipment Under Test	t				
Power supply system utilis	ed				
Power supply voltage	:	0	230V / 50 Hz	0	120V / 60Hz
		0	12V DC	0	24V DC
			Other (specified in bla	ank below) CAR

DC 3.7V From battery and DC 5.0V From external circuit

2.4 Short description of the Equipment under Test (EUT)

This is an IINE Wireless Controller.

For more details, refer to the user's manual of the EUT.

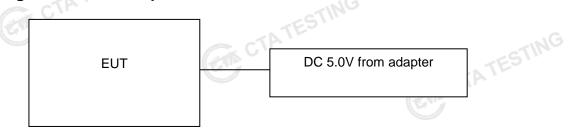
2.5 EUT operation mode

The Applicant provides communication tools software(Engineer mode) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing .There are 79 channels

Operation Frequency:

CTA '	Channel	Frequency (MHz)	
	00	2402	
and the second sec	01 CTA	2403	
		TEST	
	38	2440	
	39	2441	-17
	40	2442	CIN'
	÷	E.	
EGTIN	77	2479	
	78	2480	

Block Diagram of Test Setup 2.6



Related Submittal(s) / Grant (s) 2.7

This submittal(s) (test report) is intended for the device filing to comply with Section 15.247 of the FCC Part 15, CTA TESTING Subpart C Rules.

2.8 **Modifications**

No modifications were implemented to meet testing criteria.

TEST ENVIRONMENT 3

Address of the test laboratory 3.1

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement

CAB identifier: CN0127 ISED#: 27890

Shenzhen CTA Testing Technology Co., Ltd. has been listed by Innovation, Science and Economic Development Canada to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Environmental conditions

GA CTATESTING During the measurement the environmental conditions were within the listed ranges:

Radiated Emission:

Temperature:	24 ° C
Humidity:	45 %
Atmospheric pressure:	950-1050mbar

AC Power Conducted Emission:

Temperature:	25 ° C]
Llumiditur	46.9/	
Humidity:	46 %	STING
Atmospheric pressure:	950-1050mbar	ATES
Conducted testing:		
Temperature:	25 ° C	1

Conducted testina:

g	
Temperature:	25 ° C
Humidity:	44 %
Atmospheric pressure:	950-1050mbar
CTATESI	

3.4 Summary of measurement results

	Test Specification clause	Test case	Test Mode	Test Channel		orded eport	Test result
ľ	§15.247(a)(1)	Carrier Frequency separation	GFSK N/4DQPSK 8DPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK Π/4DQPSK 8DPSK	Middle	Compliant
	§15.247(a)(1)	Number of Hopping channels	GFSK Π/4DQPSK 8DPSK	I Full	GFSK	🛛 Full	Compliant
	§15.247(a)(1)	Time of Occupancy (dwell time)	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK Π/4DQPSK 8DPSK	🛛 Middle	Compliant
CTATE	§15.247(a)(1)	Spectrumbandwidth of aFHSS system20dB bandwidth	GFSK T/4DQPSK 8DPSK	Lowest	GFSK Π/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	Compliant
	§15.247(b)(1)	Maximum output peak power	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK T/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	Compliant
	§15.247(d)	Band edgecompliance conducted	GFSK Π/4DQPSK 8DPSK	☑ Lowest☑ Highest	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Highest	Compliant
	§15.205	Band edgecompliance radiated	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Highest	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Highest	Compliant
	§15.247(d)	TX spuriousemissions conducted	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	Compliant
	§15.247(d)	TX spuriousemissions radiated	GFSK Π/4DQPSK 8DPSK	Lowest Middle	GFSK	 ☑ Lowest ☑ Middle ☑ Highest 	Compliant
	§15.209(a)	TX spurious Emissions radiated Below 1GHz	GFSK Π/4DQPSK 8DPSK	Lowest	GFSK	Middle	Compliant
	§15.107(a) §15.207	Conducted Emissions 9KHz-30 MHz	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK	X Middle	Compliant

Remark:

1. The measurement uncertainty is not included in the test result.

2. We tested all test mode and recorded worst case in report

3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement characteristics; Part 2" and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

		eennereg, een, <u>-</u>	
Test	Range	Measurement Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.02 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	/	0.57 dB	(1)

Shenzhen CTA Testing Technology Co., Ltd.

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	Spectrum bandwidth	/	1.1%	(1)
	Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
,TP	Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
	Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)

(1)This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6 Equipments Used during the Test

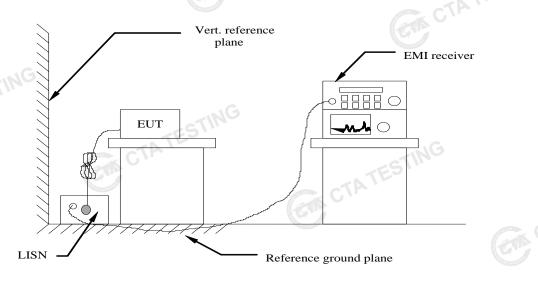
E	Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
ľ	LISN	R&S	ENV216	CTA-308	2023/08/02	2024/08/07
		R&S	ENV216	CTA-314	2023/08/02	2024/08/07
	EMI Test Receiver	R&S	ESPI	CTA-307	2023/08/02	2024/08/07
	EMI Test Receiver	R&S	ESCI	CTA-306	2023/08/02	2024/08/07
	Spectrum Analyzer	Agilent	N9020A	CTA-301	2023/08/02	2024/08/07
	Spectrum Analyzer	G R&S	FSP	CTA-337	2023/08/02	2024/08/07
	Vector Signal generator	Agilent	N5182A	CTA-305	2023/08/02	2024/08/07
1000	Analog Signal Generator	R&S	SML03	CTA-304	2023/08/02	2024/08/07
	WIDEBAND RADIO COMMUNICATION TESTER	CMW500	R&S	CTA-302	2023/08/02	2024/08/0
	Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2023/08/02	2024/08/07
	Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2024/10/16
	Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2024/10/12
	Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2024/10/10
	Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2021/08/07	2024/08/06
	Amplifier	Schwarzbeck	BBV 9745	CTA-312	2023/08/02	2024/08/07
	Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2023/08/02	2024/08/07
	Directional coupler	NARDA	4226-10	CTA-303	2023/08/02	2024/08/07
	High-Pass Filter	G XingBo	XBLBQ-GTA18	CTA-402	2023/08/02	2024/08/07
	High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2023/08/02	2024/08/07
Contraction of the Contraction	Automated filter bank	Tonscend	JS0806-F	CTA-404	2023/08/02	2024/08/0
	Power Sensor	Agilent	U2021XA	CTA-405	2023/08/02	2024/08/0
╞	Amplifier	Schwarzbeck	BBV9719	CTA-406	2023/08/02	2024/08/0

	Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date	
	EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A	
	EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A	
	RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A	
	RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A	TATE
-	TING					GIA	P.
CTATE	51	CTATESTING					
Ŷ		CTATES					

4 TEST CONDITIONS AND RESULTS

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.

2 Support equipment, if needed, was placed as per ANSI C63.10-2013

3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013

4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.

5 All support equipments received AC power from a second LISN, if any.

6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.

7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

8 During the above scans, the emissions were maximized by cable manipulation.

AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following :

Frequency range (MHz)	Limit (dBuV)				
Frequency range (Miriz)	Quasi-peak	Average			
0.15-0.5	66 to 56*	56 to 46*			
0.5-5	56	46			
5-30	60	50			
* D					

* Decreases with the logarithm of the frequency.

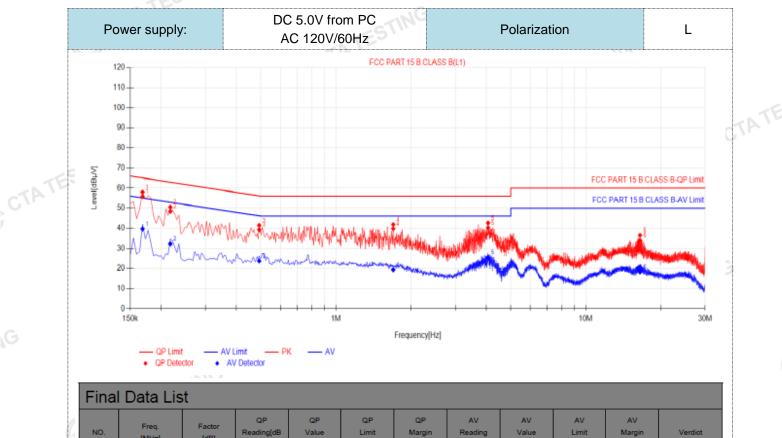
TEST RESULTS

Remark:

1. All modes of GFSK, Π/4 DQPSK and 8DPSK were test at Low, Middle, and High channel; only the worst result of GFSK Middle Channel was reported as below:

TATE

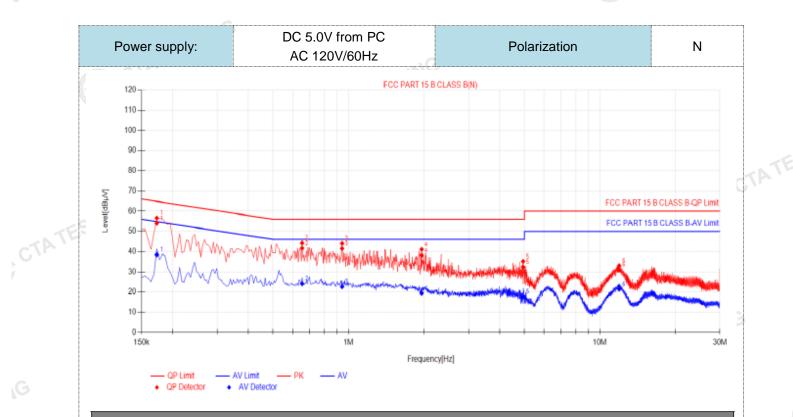
2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:



NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict
1	0.168	9.95	45.87	55.82	65.06	9.24	29.67	39.62	55.06	15.44	PASS
2	0.2175	10.04	38.31	48.35	62.91	14.56	22.25	32.29	52.91	20.62	PASS
3	0.492	10.01	29.24	39.25	56.13	16.88	13.75	23.76	46.13	22.37	PASS
4	1.6935	9.91	29.78	39.69	56.00	16.31	9.46	19.37	46.00	26.63	PASS
5	4.0695	9.92	30.26	40.18	56.00	15.82	15.57	25.49	46.00	20.51	PASS
6	16.467	10.34	23.62	33.96	60.00	26.04	7.92	18.26	50.00	31.74	PASS

Note:1).QP Value $(dB\mu V)$ = QP Reading $(dB\mu V)$ + Factor (dB)

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). $QPMargin(dB) = QP Limit (dB\mu V) QP Value (dB\mu V)$
 - CTATESTING 4). AVMargin(dB) = AV Limit (dBμV) - AV Value (dBμV)



Final Data List

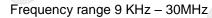
NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict	
1	0.1725	10.07	43.94	54.01	64.84	10.83	28.38	38.45	54.84	16.39	PASS	
2	0.654	10.10	31.58	41.68	56.00	14.32	14.10	24.20	46.00	21.80	PASS	
3	0.942	10.12	31.39	41.51	56.00	14.49	12.53	22.65	46.00	23.35	PASS	
4	1.9545	10.19	27.99	38.18	56.00	17.82	9.26	19.45	46.00	26.55	PASS	
5	4.9425	10.08	22.23	32.31	56.00	23.69	7.47	17.55	46.00	28.45	PASS	
6	11.949	10.41	20.50	30.91	60.00	29.09	10.99	21.40	50.00	28.60	PASS	-KA'
Note:1)	Note:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB)											
2). Fact	tor (dB)=ir		oss of LIS	. ,		• • •)					

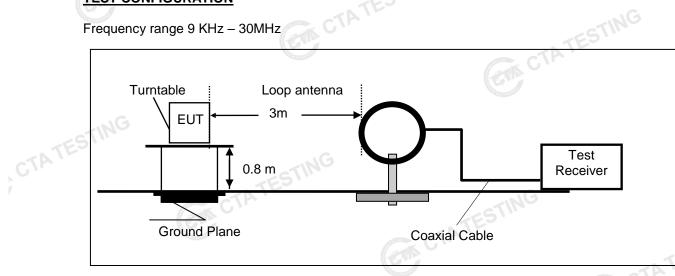
Note:1).QP Value ($dB\mu V$)= QP Reading ($dB\mu V$)+ Factor (dB) 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB) 3). QPMargin(dB) = QP Limit (dB μ V) - QP Value (dB μ V)

4). AVMargin(dB) = AV Limit (dB μ V) - AV Value (dB μ V) CTA TESTING

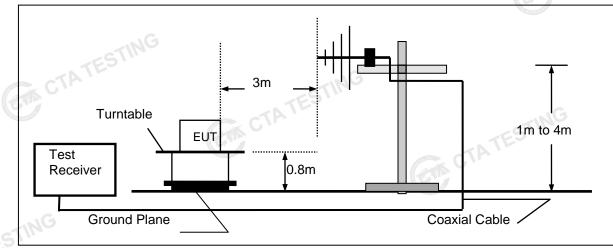
4.2 **Radiated Emission**

TEST CONFIGURATION

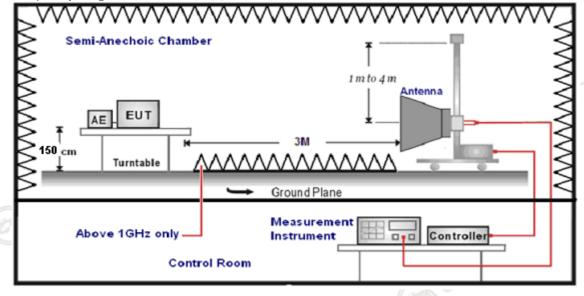




Frequency range 30MHz - 1000MHz



Frequency range above 1GHz-25GHz



6.

TEST PROCEDURE

- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz -1GHz; the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz - 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT.
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- Radiated emission test frequency band from 9KHz to 25GHz. 5.

The distance between test antenna and EUT as following table states:								
Test Frequency range	Test Antenna Type	Test Distance						
9KHz-30MHz	Active Loop Antenna	3						
30MHz-1GHz	Ultra-Broadband Antenna	3						
1GHz-18GHz	Double Ridged Horn Antenna	3						
18GHz-25GHz	Horn Anternna	1						

Setting test receiver/spectrum as following table states: 7.

Setting test receiver/spectrum as following table states.							
Test Frequency range	Test Receiver/Spectrum Setting	Detector					
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP					
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP					
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP					
	Peak Value: RBW=1MHz/VBW=3MHz,						
1GHz-40GHz	Sweep time=Auto	Peak					
19112-409112	Average Value: RBW=1MHz/VBW=10Hz,	reak					
	Sweep time=Auto						

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS = RA + AF + CL - AG

sample calculation is as follows.	STINE				
FS = RA + AF + CL - AG	CTATES				
Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)				
RA = Reading Amplitude	AG = Amplifier Gain				
AF = Antenna Factor					

Transd=AF +CL-AG

RADIATION LIMIT

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)		
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)		
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)		
1.705-30	3	20log(30)+ 40log(30/3)	30		
30-88	3	40.0	100		
88-216	3	43.5	150		
216-960	3	46.0	200		
Above 960	3	54.0	500		

Report No.: CTA24042300701

TATE

CTATESTING

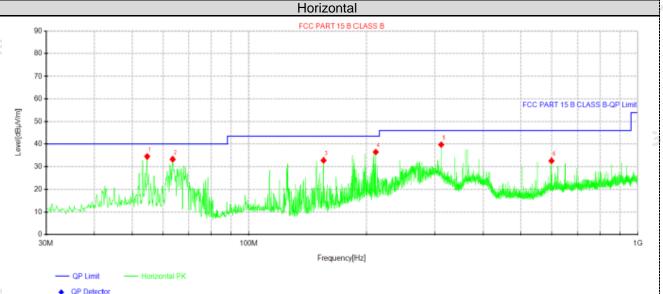
TEST RESULTS

Remark:

CTATE

- This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X 1. position.
- We measured Radiated Emission at GFSK, π/4 DQPSK and 8DPSK mode from 9 KHz to 25GHz and 2. recorded worst case at GFSK DH5 mode.
- For below 1GHz testing recorded worst at GFSK DH5 middle channel. 3.
- Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found 4. except system noise floor in 9 KHz to 30MHz and not recorded in this report.





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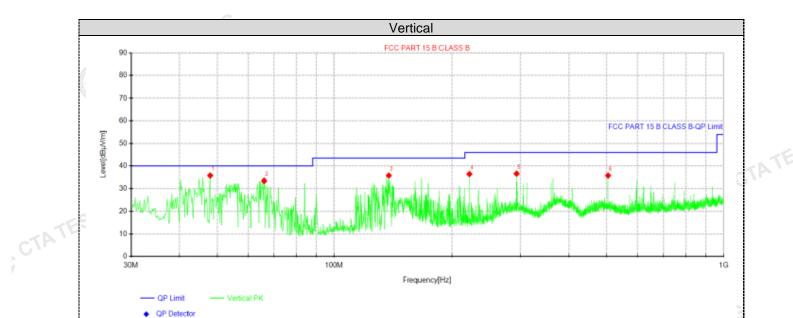
	Suspected Data List										
	NO.	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Polarity	
	NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Folanty	
	1	54.735	46.42	34.51	-11.91	40.00	5.49	100	0	Horizontal	
	2	63.5862	47.32	33.32	-14.00	40.00	6.68	100	0	Horizontal	
	3	155.978	49.08	32.86	-16.22	43.50	10.64	100	234	Horizontal	
	4	211.39	49.65	36.43	-13.22	43.50	7.07	100	210	Horizontal	
[5	311.906	51.05	39.71	-11.34	46.00	6.29	100	303	Horizontal	
	6	599.996	37.95	32.69	-5.26	46.00	13.31	100	61	Horizontal	

Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m)

CTATE



Suspected Data List

Jusp	Suspected Data List									
NO.	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Polarity	
NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Folanty	
1	47.945	47.28	35.72	-11.56	40.00	4.28	100	274	Vertical	
2	66.0112	47.87	33.46	-14.41	40.00	6.54	100	191	Vertical	
3	138.276	51.97	35.70	-16.27	43.50	7.80	100	296	Vertical	
4	221.938	49.42	36.38	-13.04	46.00	9.62	100	262	Vertical	
5	293.355	48.18	36.55	-11.63	46.00	9.45	100	360	Vertical	
6	503.966	44.94	35.71	-9.23	46.00	10.29	100	32	Vertical	

Note:1).Level ($dB\mu V/m$) = Reading ($dB\mu V$) + Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m)

For 1GHz to 25GHz

Note: GFSK , $\pi/4$ DQPSK and 8DPSK all have been tested, only worse case GFSK is reported. GFSK (above 1GHz)

Frequency(MHz):			2402		Polarity:		HORIZONTAL		
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4804.00	62.40	PK	74	11.60	66.67	32.33	5.12	41.72	-4.27
4804.00	45.45	AV	54	8.55	49.72	32.33	5.12	41.72	-4.27
7206.00	52.25	PK	74	21.75	52.77	36.6	6.49	43.61	-0.52
7206.00	42.47	AV	54	11.53	42.99	36.6	6.49	43.61	-0.52

. G									G
Freque	Frequency(MHz):		2402		Polarity:		VERTICAL		
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4804.00	60.58	PK	74	13.42	64.85	32.33	5.12	41.72	-4.27
4804.00	43.42	AV	54	10.58	47.69	32.33	5.12	41.72	-4.27
7206.00	49.92	PK	74	24.08	50.44	36.6	6.49	43.61	-0.52
7206.00	40.88	AV	54	13.12	41.40	36.6	6.49	43.61	-0.52

Frequency(MHz):			2441		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	/el	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4882.00	61.93	PK	74	12.07	65.81	32.6	5.34	41.82	-3.88
4882.00	44.30	AV	54	9.70	648.18	32.6	5.34	41.82	-3.88
7323.00	52.31	PK	74	21.69	52.42	36.8	6.81	43.72	-0.11
7323.00	42.34	AV	54	11.66	42.45	36.8	6.81	343.72	-0.11
			Carlo V				STIN		

Frequency(MHz):			2441		Polarity:		VERTICAL			
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4882.00	60.03	PK	74	13.97	63.91	32.6	5.34	41.82	-3.88	
4882.00	42.17	AV	54	11.83	46.05	32.6	5.34	41.82	-3.88	
7323.00	50.74	PK	74	23.26	50.85	36.8	6.81	43.72	-0.11	
7323.00	40.79	AV	54	13.21	40.90	36.8	6.81	43.72	-0.11	
			ES.							

Frequency(MHz):		2480		Polarity:		HORIZONTAL			
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	61.20	PK	74	12.80	64.28	32.73	5.66	41.47	-3.08
4960.00	45.63	AV	54	8.37	48.71	32.73	5.66	41.47	-3.08
7440.00	53.50	PK	74	20.50	53.05	37.04	7.25	43.84	0.45
7440.00	42.36	PK	54	11.64	41.91	37.04	7.25	43.84	0.45

Frequency(MHz):			24	80	Polarity:		VERTICAL		
Frequency (MHz)	_	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	G Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	59.32	PK	74	14.68	62.40	32.73	5.66	41.47	-3.08
4960.00	43.28	AV	54	10.72	46.36	32.73	5.66	41.47	-3.08
7440.00	51.75	PK	74	22.25	51.30	37.04	7.25	43.84	0.45
7440.00	40.82	PK	54	13.18	40.37	37.04	7.25	43.84	0.45

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REMARKS:

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

Results of Band Edges Test (Radiated)

Note: GFSK, π/4 DQPSK and 8DPSK all have been tested, only worse case GFSK is reported.

	,			GFS		9			
Freque	ncy(MHz)	:	24	02	Pola	rity:	н	IORIZONT/	AL.
Frequency (MHz)	Emis Le [.] (dBu	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	62.22	PK	74	11.78	72.64	27.42	4.31	42.15	-10.42
2390.00	43.06	AV	54	10.94	53.48	27.42	4.31	42.15	-10.42
Freque	ncy(MHz)	:	24	02	Pola	rity:		VERTICAL	
Frequency (MHz)	Emis Le ^v (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	60.56	PK	74	13.44	70.98	27.42	4.31	42.15	-10.42
2390.00	40.56	AV	54	13.44	50.98	27.42	4.31	42.15	-10.42
Freque	ncy(MHz)	:	24	80	Pola	rity:	HORIZONTAL		AL.
Frequency (MHz)	Emis Le ^v (dBu	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	61.34	PK	74	12.66	71.45	27.7	4.47	42.28	-10.11
2483.50	44.56	AV	54	9.44	54.67	27.7	4.47	42.28	-10.11
Freque	ncy(MHz)	:	24	80	Pola	rity:	VERTICAL		
Frequency (MHz)	Emis Le (dBu	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	59.67	PK	74	14.33	69.78	27.7	4.47	42.28	-10.11
2483.50	42.10	AV	54	11.90	52.21	27.7	4.47	42.28	-10.11
REMARKS									

REMARKS:

1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)

2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier

3. Margin value = Limit value- Emission level.

CTA TESTING 4. -- Mean the PK detector measured value is below average limit.

5. The other emission levels were very low against the limit.

Maximum Peak Output Power 4.3

Limit

The Maximum Peak Output Power Measurement is 125mW (20.97).

Test Procedure

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to CTATE the powersensor.

Test Configuration CTATESTING



Test Results

Type Channel Output power (dBm) Limit (dBm) Res GFSK 00 -1.49 20.97 Pa 78 -1.83 20.97 Pa 00 -2.86 20.97 Pa 78 -3.21 20.97 Pa
GFSK 39 -1.85 20.97 Pa 78 -1.83
78 -1.83 00 -2.86 π/4DQPSK 39 -3.21 20.97 Pa 78 -3.13 -3.13 -3.13 Pa
π/4DQPSK 00 -2.86 20.97 Pa 78 -3.13 20.97 Pa
π/4DQPSK 39 -3.21 20.97 Pa 78 -3.13
78 -3.13
00 -2.84
8DPSK 39 -3.25 20.97 Pa
78 -3.14 Note: 1.The test results including the cable lose.

20dB Bandwidth 4.4

Limit

For frequency hopping systems operating in the 2400MHz-2483.5MHz no limit for 20dB bandwidth.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

Test Configuration



Test Results

<u>Test Results</u>			CTATESTIN
Modulation	Channel	20dB bandwidth (MHz)	Result
ING	CH00	1.020	
GFSK	CH39	0.954	
CTA	CH78	0.960	
G	CH00	1.281	NG
π/4DQPSK	CH39	1.281	Pass
	CH78	1.278	
	CH00	1.281	
8DPSK	CH39	1.278	G
ING	CH78	1.314	E.

Test plot as follows:

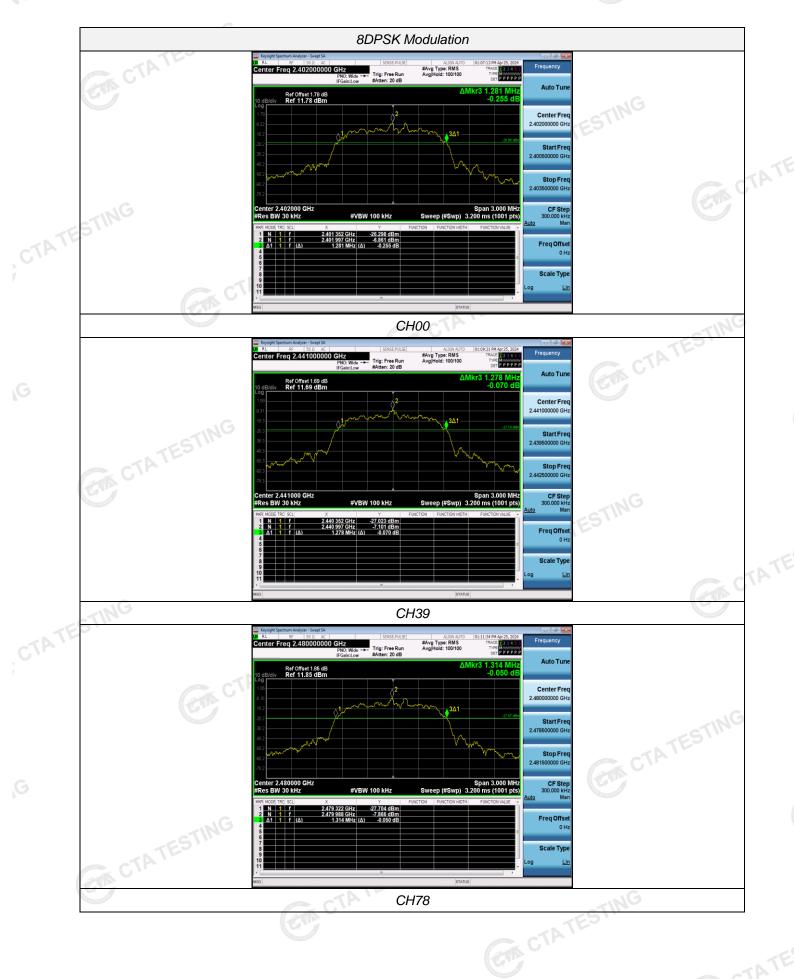












Frequency Separation 4.5

LIMIT

According to 15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the 2/3*20dB bandwidth of the hopping channel, whichever is greater.

TEST PROCEDURE

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with100 KHz RBW and 300 KHz VBW.

TEST CONFIGURATION



TEST RESULTS

TEST RESULTS		CTATE	,	TESTING	
Modulation	Channel	Channel Separation (MHz)	Limit(MHz)	Result	
GFSK	CH38	1.012	25KHz or 2/3*20dB	Pass	
Gron	CH39	1.012	bandwidth	Fass	
THADODEK S	CH38	1 240	25KHz or 2/3*20dB	Deee	
π/4DQPSK	CH39	1.340	bandwidth	Pass	
8DPSK	CH38	1 224	25KHz or 2/3*20dB	Daga	
ODPSK	CH39	1.324	bandwidth	Pass	

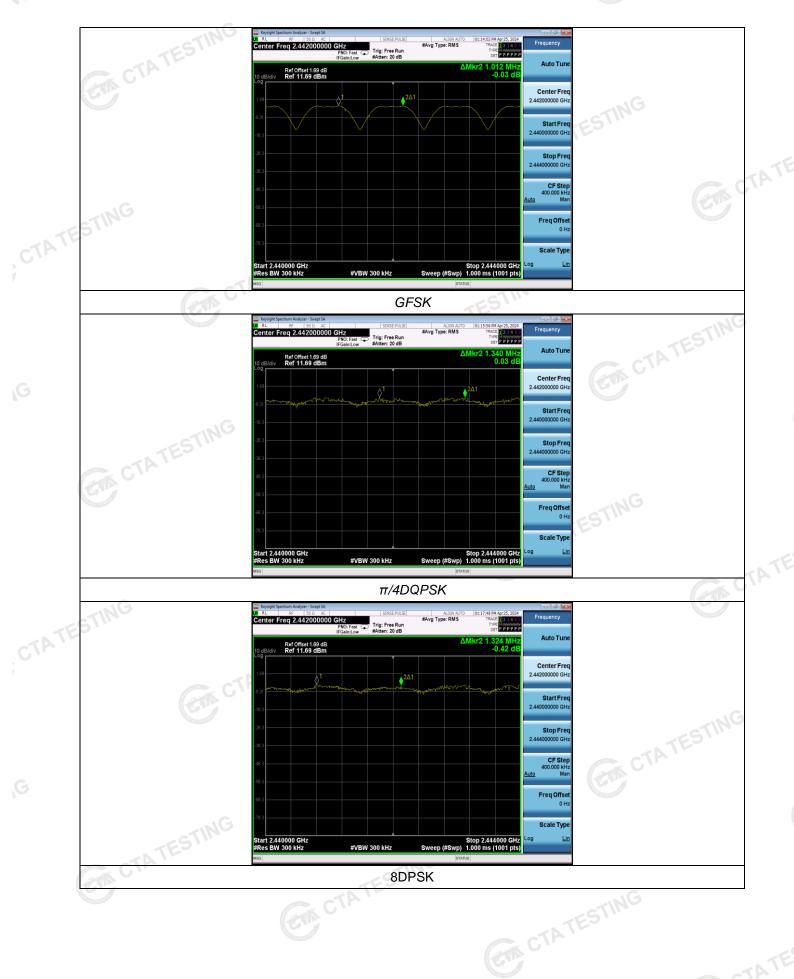
Note:

We have tested all mode at high, middle and low channel, and recorded worst case at middle

Test plot as follows: CTA TESTING

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Number of hopping frequency 4.6

Limit C

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels.

Test Procedure

GTA CTATE The transmitter output was connected to the spectrum analyzer through an attenuator. Set spectrum analyzer start 2400MHz to 2483.5MHz with 100 KHz RBW and 300 KHz VBW.

Test Configuration CTATES



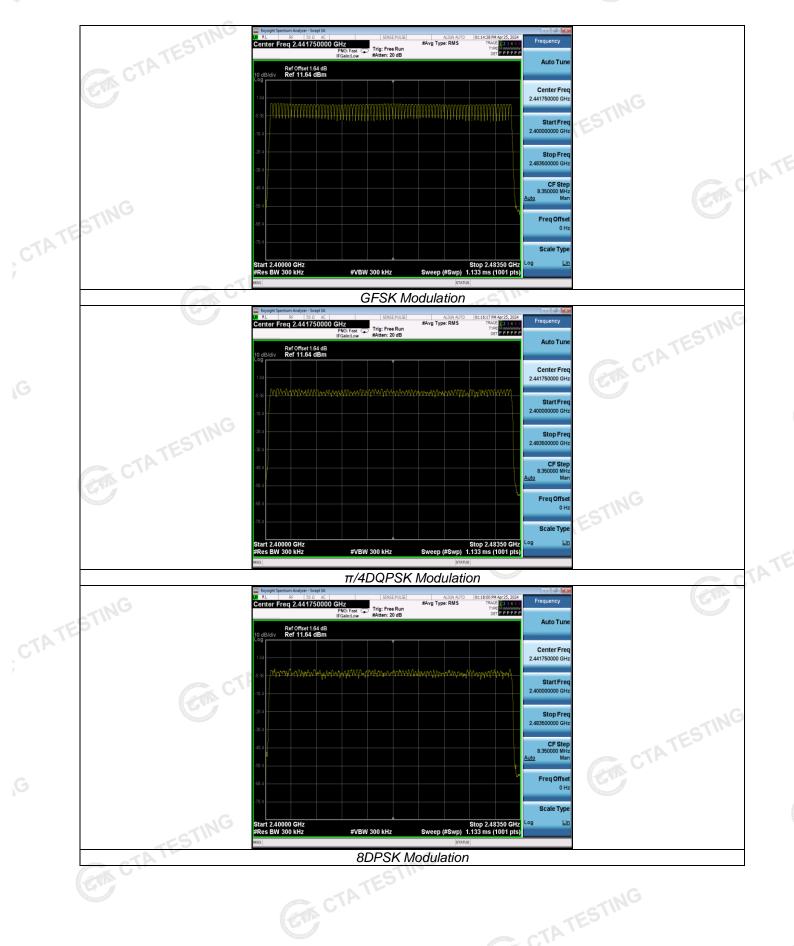
Test Results

Test Results			STING
Modulation	Number of Hopping Channel	Limit	Result
GFSK	79	(61	A. C.
π/4DQPSK	79	≥15	Pass
8DPSK	79		

Test plot as follows:

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Time of Occupancy (Dwell Time) 4.7

Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set center frequency of spectrum analyzer=operating frequency with 1MHz RBW and 1MHz VBW, Span 0Hz.

Test Configuration



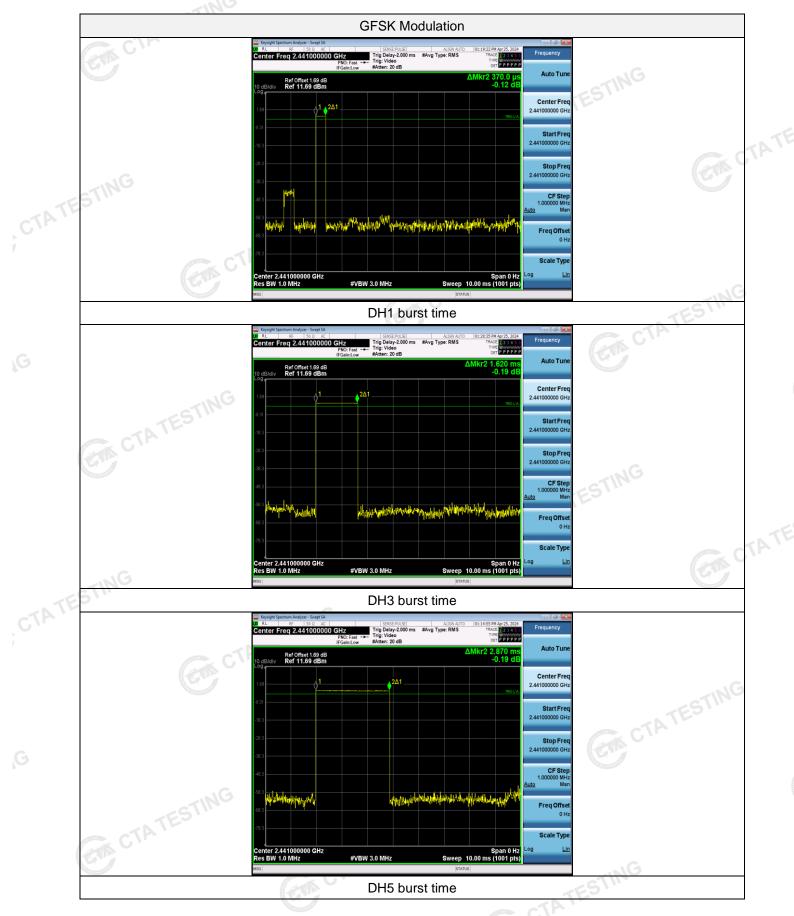
Test Results

		G			TES
Modulation	Packet	Burst time (ms)	Dwell time (s)	Limit (s)	Result
	DH1	0.37	0.118		
GFSK	CDH3	1.62	0.259	0.40	Pass
TES	DH5	2.87	0.306		
CIL	2-DH1	0.36	0.115		
π/4DQPSK	2-DH3	1.62	0.259	0.40	Pass
	2-DH5	2.88	0.307	TESTIN	
	3-DH1	0.36	0.115	CTA '	
8DPSK	3-DH3	1.62	0.259	0.40	Pass
	3-DH5	2.88	0.307		GA
TING					C.

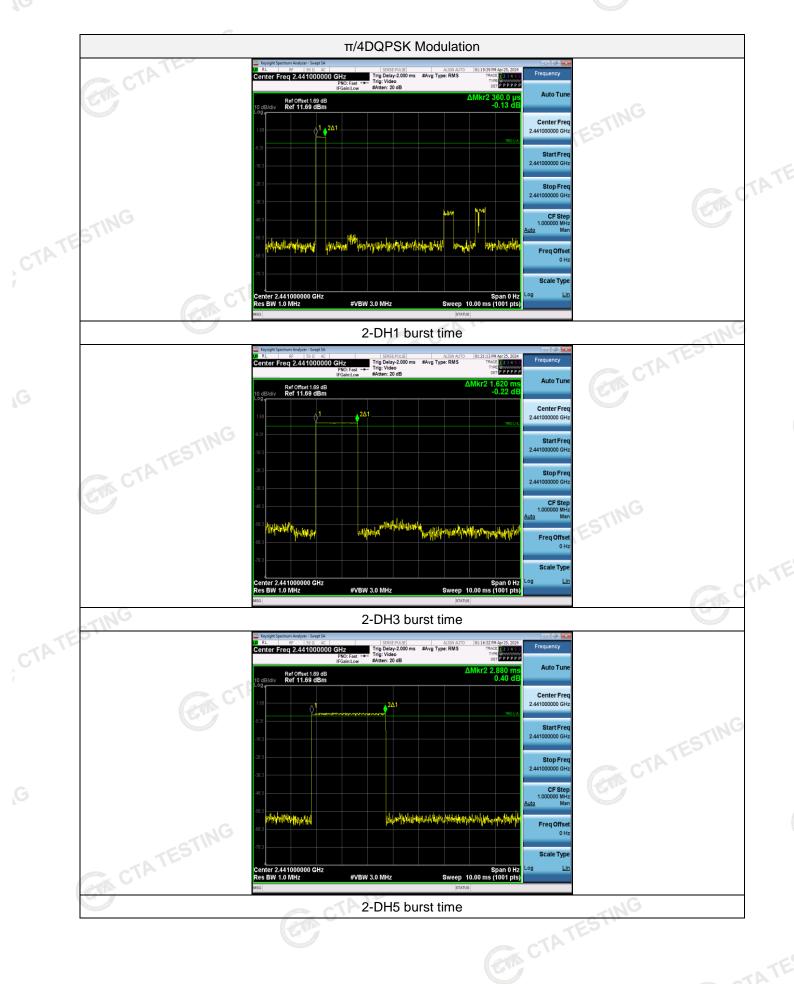
Note:We have tested all mode at high, middle and low channel, and recoreded worst case at middle channel. Dwell time=Pulse time (ms) x (1600 \div 2 \div 79) x31.6 Second for DH1, 2-DH1, 3-DH1 Dwell time=Pulse time (ms) × (1600 ÷ 4 ÷ 79) ×31.6 Second for DH3, 2-DH3, 3-DH3 Dwell time=Pulse time (ms) x (1600 ÷ 6 ÷ 79) x31.6 Second for DH5, 2-DH5, 3-DH5

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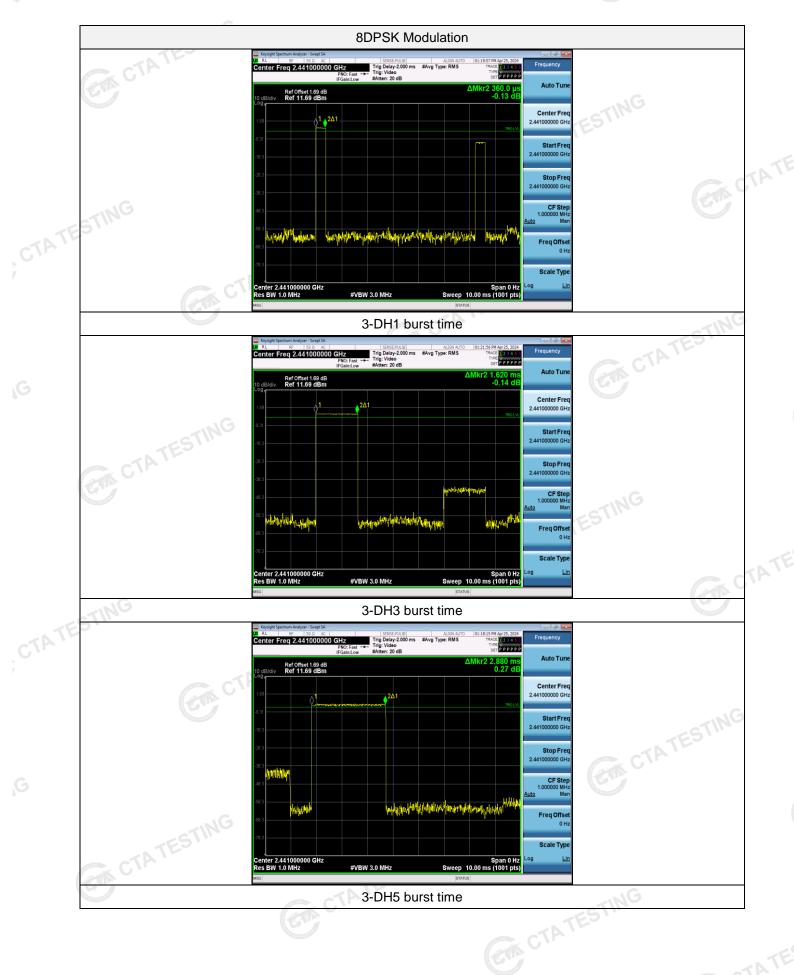
Test plot as follows:



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Out-of-band Emissions 4.8

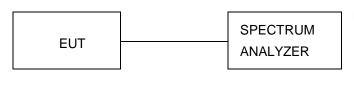
Limit C

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

Test Procedure

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector, and max hold. Measurements utilizing these setting are GTA CTATESTING made of the in-band reference level, bandedge and out-of-band emissions.

Test Configuration



Test Results

Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage measurement data.

We measured all conditions (DH1, DH3, DH5) and recorded worst case at DH5

Test plot as follows:

